

## **Notice of References Cited**

Application/Control No.  
09/839,946

Applicant(s)/Patent Under Reexam  
Williams et al.

Examiner  
Tekchand Saidha

Art Unit  
1652

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### U.S. PATENT DOCUMENTS

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification<sup>2</sup></b>
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### FOREIGN PATENT DOCUMENTS

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T					

### NON-PATENT DOCUMENTS

	<b>Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages</b>	
U	Motojima et al. JBC 263 (32) : 16677-16681 (1988)	
V	Wu et al. [PNAS, USA, Vol. 86, pp. 9412-9416, December 1989].	
W	Sigma Catalog (1993), page no. 1002, Product Nos. U 3250, 292-8, U3500, U 9375 or U 3377.	
X		

<sup>1</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

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